# Calculating Efficiency Uncertainties

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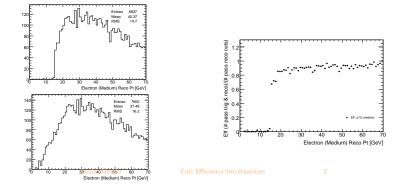
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### Efficiency Errors

o previously presented trigger efficiency curves (vs pt, eta, phi) for top trigger selections with default ROOT error bars

- o got me thinking about how to correctly calculate the statistical errors for bin-by-bin efficiency and overall efficiency
- o not as trivial as first expected ...
- o lots of papers about this topic, so here is a summary of what I found ...



### References

G. Cowan, Error Analysis for efficiency, July 28, 2008 (ATLASStatisticsFAQ wiki)
D. Casadei, How to measure efficiency, July 12, 2009 (ATLASStatisticsFAQ wiki)
T. Ullrich and Z. Xu, Treatment of Errors in Efficiency Caculations, January 17, 2007 (physics/0701199v1)

#### Notation

o let k (k<sub>i</sub>) = total number of selected events (in bin i)
o let n (n<sub>i</sub>) = total number of events (in bin i)
o want to measure efficiency ε = k/n (efficiency for bin i, ε<sub>i</sub> = k<sub>i</sub>/n<sub>i</sub>)
o and assign an uncertainty to the calculated ε (based on the measured quantities)

From here on just use the notation k, n, but can apply to individual bins  $k_i$ ,  $n_i$ 

# Default in ROOT

o TH1::Divide supposed to be standard propagation of errors assuming independent variables m, n (which is not true as these are highly correlated, m and subset of n)

o but when I checked it was just the square-root of the bin efficiency (very wrong, ex. 0.8  $\pm$  0.89)  $\ref{eq:scalar}$ 

### **Poisson Statistics**

o for large sample limit uncertainties are:

$$k \pm \sigma_k = k \pm \sqrt{k}$$
$$n \pm \sigma_n = n \pm \sqrt{n}$$

o assuming k and n independent (incorrect, k a subset of n):

• estimator of (unknown) efficiency :  $E(\epsilon) = \hat{\epsilon} = k/n$ 

• variance : 
$$V(\hat{\epsilon}) = \sigma_{\hat{\epsilon}}^2 = \hat{\epsilon}^2 (rac{1}{k} + rac{1}{n})$$

o problems with model:

- *n* fixed quantity, well defined and known ( $\sigma_n = 0$ ), so  $V(\hat{\epsilon}) = k/n^2$
- n and k highly correlated
- limiting cases where  $k = 0 \rightarrow \hat{\epsilon} \pm 0$ , even if observed one event (n = 1) and it fails (k = 0) we know with complete certainty (zero error) the efficiency is zero

### **Binomial Statistics**

o k successes out of n independent trials, k binomially distributed o probability of success is a function of true efficiency  $\epsilon$ :

$$P(k; n, \epsilon) = \frac{n!}{k!(n-k)!} \epsilon^k (1-\epsilon)^{n-k}$$

o for binomially distributed k:

- estimator :  $k = n\epsilon$
- variance :  $V(k) = \sigma_k^2 = n\epsilon(1-\epsilon)$

o for unknown quantity  $\epsilon$  (assuming *n* known with zero error, has no dependence on parameter of interest  $\epsilon$ ):

- assume usual estimator :  $E(\epsilon) = \hat{\epsilon} = k/n$
- variance via propagation of errors :  $V(\hat{\epsilon}) = \sigma_{\hat{\epsilon}}^2 = V(k/n) = \frac{V(k)}{n^2} = \frac{\epsilon(1-\epsilon)}{n}$

o in ROOT apparently can use TH1:Divide option "B" for errors to be calculated using this binomial method (I tried it ... and it didn't work ...)

Calc Efficiency Uncertainties

# **Binomial Statistics**

- o problems with model:
  - *ϵ* is the quantity we are determining through measurements of *k* and *n*, yet
     uncertainty of measured *ϵ* depends on true *ϵ*
  - limiting cases where  $k=0
    ightarrow \hat{\epsilon}\pm 0$ , as with Poisson model
  - if  $k = n \rightarrow \epsilon = 1$  error is zero

#### **Bayesian Statistics**

o determine probability that  $\hat{\epsilon}$  is the true efficiency given the measurements of k and n:

$$P(\epsilon; k, n) = \frac{P(k; \epsilon, n)P(\epsilon; n)}{C}$$

o where  $P(k; \epsilon, n)$  is the probability of k given a certain  $\epsilon$  and n, and is the binomial probability given two slides ago

o *C* is the overall normalization constant (proven in Ullrich and Xu)  $C = \frac{1}{n+1}$ o and  $P(\epsilon; n)$  is the probability of  $\epsilon$  given a value of *n*, prior before any measurements taken leads us to assume  $P(\epsilon; n)$  is uniform [0, 1] ( $\epsilon$  can take any value between 0 and 1 regardless of *n*)

o the final efficiency probability function is:

$$P(\epsilon; k, n) = \frac{(n+1)!}{k!(n-k)!} \epsilon^k (1-\epsilon)^{n-k}$$

Bayesian Statistics: n = 10

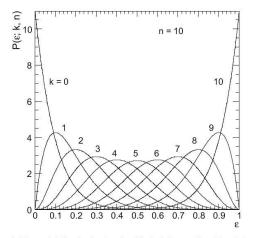


Figure 1: The probability density function  $P(\varepsilon; k, n)$  for n = 10 and  $k = 0, 1, \dots, 10$ .

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Bayesian Statistics: n = 100

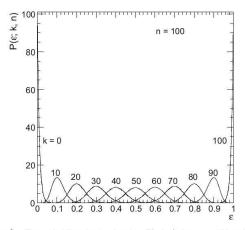


Figure 2: The probability density function  $P(\varepsilon; k, n)$  for n = 100 and  $k = 0, 10, \dots, 100$ .

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### Bayesian Statistics: Efficiency

o for the efficiency we can calculate the moments, and one find:

- mean:  $\overline{\epsilon} = \frac{k+1}{n+2}$
- mode (most probably value,  $dP/d\epsilon = 0$ ) : mode( $\epsilon$ ) =  $\frac{k}{n}$

o interesting to note:

- mean value not as typically expected, mode is what we call efficiency, and mode
   mean when n = 2k (mid-value, symmetric distribution), and for large n
- papers claim mean is biased for small n
- for small n and/or small k, the values for the mode and mean are different

### Bayesian Statistics: Variance

o the variance of the efficiency is (proof in Ullrich and Xu):

$$V(\epsilon) = \frac{(k+1)(k+2)}{(n+2)(n+3)} - \frac{(k+1)^2}{(n+2)^2}$$

o interesting points about the variance:

- now note that variance behaves correctly for the extreme cases of k = 0 and k = n
- for k=n as n gets large  $V(\epsilon) 
  ightarrow 1/n^2$
- for n = 0 the mean and variance is non-zero (ϵ
   = 1/2 and V(ϵ) = 1/12, mean
   and variance for a uniform distribution with range (0, 1)).
- · dependent only on variables that are measured or known
- does not work if k > n (variance negative)

according to references listed this is the correct treatment of the statistical uncertainty of the efficiency Calc Efficiency Uncertainties 13

#### Bayesian Statistics: Mode Vs Mean

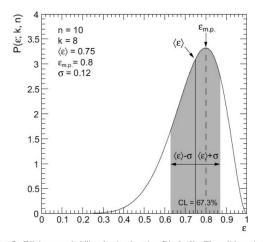


Figure 3: Efficiency probability density function  $P(\varepsilon; 8, 10)$ . The solid vertical li depicts the mean value, the dashed line the most probable value. The gray shad region corresponds to plus/minus one standard deviation (Eq. [19]) around the mea

### Results

o example of different techniques for my top trigger analysis (105200, r635,  ${\approx}30k$  events)

o two examples of a particular bin (low and high statistics)

Method	Numerator	Denominator	Mean (Mode)	Variance	Uncertainty $\sigma$
Poisson	1	45	0.0222	0.00050	0.02246
Binomial	1	45	0.0222	0.00048	0.02197
Bayesian	1	45	0.04255 (0.0222)	0.00085	0.02913

Method	Numerator	Denominator	Mean (Mode)	Variance	Uncertainty $\sigma$
Poisson	100	106	0.9433	0.01729	0.13151
Binomial	100	106	0.9433	0.00050	0.02244
Bayesian	100	106	0.9352 (0.9433)	0.00056	0.02358



o still not sure if Bayesian method is right - which value of efficiency to use? mode or mean, these vary greatly at low n and k

o statistics experts seem to agree Bayesian method is the correct way of calculating the variance on the efficiency

o does this properly take into account correlations between k and n?

o interesting to think about ...